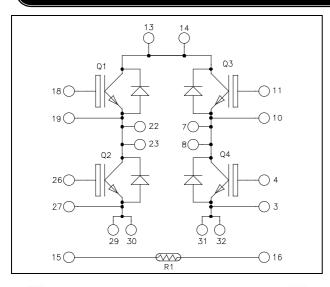
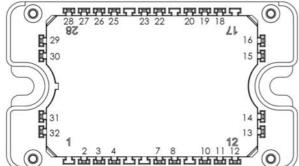


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Full bridge High speed Trench + Field Stop IGBT4 Power Module





All multiple inputs and outputs must be shorted together Example: 13/14 ; 29/30 ; 22/23 ...

# APTGLQ75H120T3G

# $V_{CES} = 1200V$

 $I_C = 75A$  @  $T_c = 80^{\circ}C$ 

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- High speed Trench + Field Stop IGBT 4
  - Low voltage drop
  - Low leakage current
  - Low switching losses
- Kelvin emitter for easy drive
- Very low stray inductance
- Internal thermistor for temperature monitoring

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS compliant

## All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

### Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Voltage		1200	V
т	Continuous Collector Connect	$T_C = 25^{\circ}C$	130	
Ic	Continuous Collector Current $T_{C} = 80^{\circ}C$		75	А
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	250	
$V_{GE}$	Gate – Emitter Voltage		±20	V
PD	Power Dissipation		385	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

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### Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} =$			50	μΑ	
Varia	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	1.7	2.05	2.4	V
V <sub>CE(sat)</sub>		$I_C = 75A$ $T_j = 150^{\circ}C$			2.6		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 2.6 \text{ mA}$		5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				150	nA

## Dynamic Characteristics (per IGBT)

v	<i>Characteristic</i>	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		4400		
Coes	Output Capacitance	$V_{CE} = 25V$		250		pF
Cres	Reverse Transfer Capacitance	f = 1 MHz		235		
$Q_{G}$	Gate charge	$V_{GE} = 15V, I_C = 75A$ $V_{CE} = 960V$		325		nC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		30		
Tr	Rise Time	$V_{GE} = \pm 15V$		57		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_C = 75A$		290		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 7\Omega$		16		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C)		30		
Tr	Rise Time	$V_{GE} = \pm 15V$		49		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 75A$		366		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 7\Omega$		48		
Eon	Turn on Energy	$V_{GE} = \pm 15V$ $T_j = 25^{\circ}C$		5.5		
2011		$V_{Bus} = 600V$ $T_j = 150^{\circ}C$		6.4		mJ
$E_{\text{off}}$	Turn off Energy	$I_{C} = 75A \qquad T_{j} = 25^{\circ}C \\ R_{G} = 7\Omega \qquad T_{i} = 150^{\circ}C$		2.05 3.84		
Isc	Short Circuit data	$\begin{array}{c} V_{GE} \leq 15V \; ; \; V_{Bus} = 900V \\ t_p \leq 10 \mu s \; ; \; T_j = 150^{\circ} C \end{array}$		260		А
$R_{thJC}$	Junction to Case Thermal Resistance				0.39	°C/W

### Diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					1200	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =1200V	V <sub>R</sub> =1200V			150	μΑ
$I_{\rm F}$	DC Forward Current		$Tc = 80^{\circ}C$		60		А
$V_{\rm F}$	Diode Forward Voltage	$I_F = 60A$			2.6	3.1	
		$I_F = 120A$			3.2		V
		$I_F = 60A$	$T_j = 125^{\circ}C$		1.8		
t <sub>rr</sub>	Reverse Recovery Time		$T_j = 25^{\circ}C$		300		
		$I_F = 60A$	$T_j = 125^{\circ}C$		380		ns
Qn	Reverse Recovery Charge	$V_R = 800V$ di/dt = 400A/us	$T_j = 25^{\circ}C$		720		nC
		•	$T_j = 125^{\circ}C$		3400		nC
$R_{\text{thJC}}$	Junction to Case Thermal Resistance					0.65	°C/W

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### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic	, ,	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%
	D					

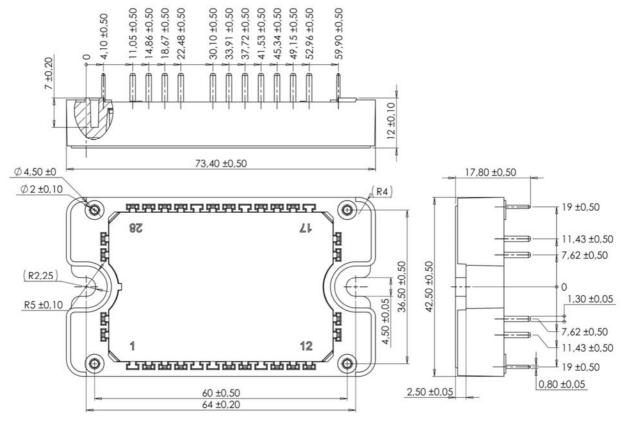
 $R_{T} = \frac{K_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad \text{T:} \\ R_{T}$ 

T: Thermistor temperature  $R_T$ : Thermistor value at T

### Thermal and package characteristics

Symbol	Characteristic	Min	Max	Unit		
VISOL	RMS Isolation Voltage, any terminal to case	4000		V		
T <sub>J</sub>	Operating junction temperature range				175	
T <sub>JOP</sub>	Recommended junction temperature under s	ions	-40	T <sub>J</sub> max -25	°C	
T <sub>STG</sub>	Storage Temperature Range	-40	125	C		
T <sub>C</sub>	Operating Case Temperature	-40	125			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

## Package outline (dimensions in mm)



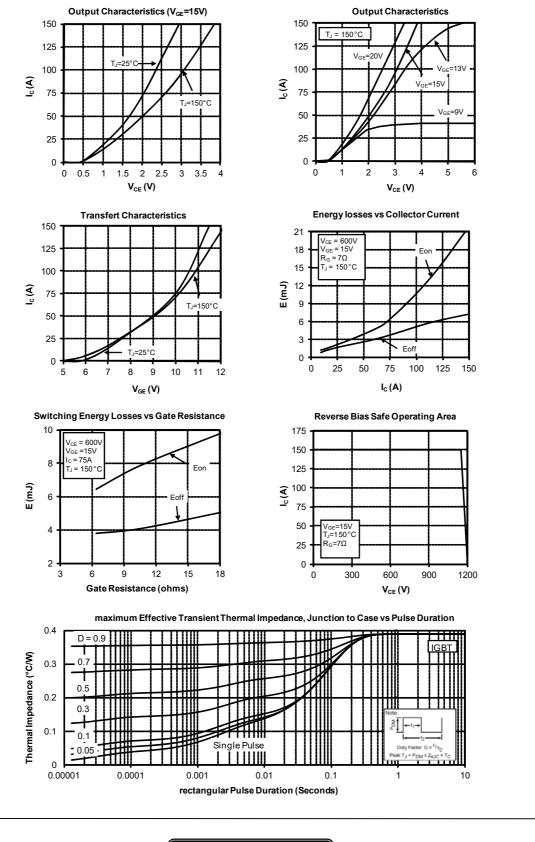
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

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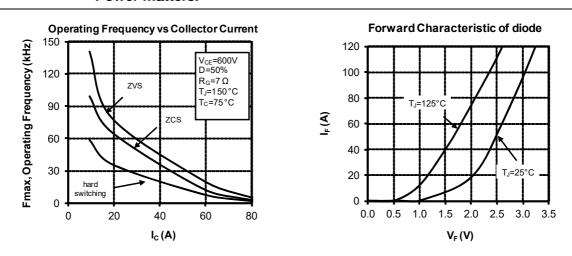
## Typical performance curve

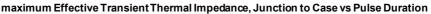


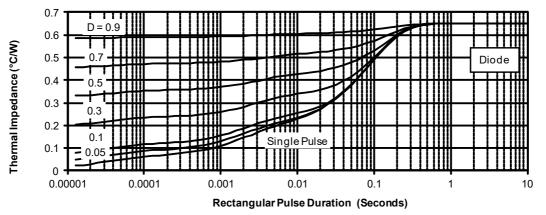
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